

INF 5300 – Introduction II/II

- Feature-based classification basics (reminder)

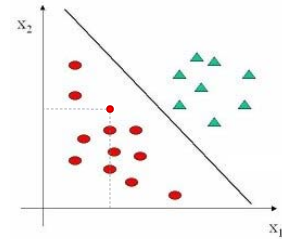
Background material: The INF4300 lecture notes and supporting material on classification.

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All there is to it I / II



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All there is to it II / II

- Task: Classify object $x = \{x_1, \dots, x_n\}$ to one of K classes $\omega_1, \dots, \omega_K$
- **Decision rule** $f(\mathbf{x}) = \omega_i$ divides the feature space into K disjoint subsets $R_i, i=1, \dots, K$.
- The decision rule is often defined by K scalar **discriminant functions** $g_1(\mathbf{x}), \dots, g_K(\mathbf{x})$
- The pattern \mathbf{x} will be classified to the class whose discriminant function gives a maximum:
$$f(\mathbf{x}) = \omega_i \Leftrightarrow g_i(\mathbf{x}) = \max_{j=1, \dots, K} g_j(\mathbf{x})$$
- Discriminant hypersurfaces are thus defined by $g_i(\mathbf{x}) - g_j(\mathbf{x}) = 0$
- **Training data** vs test/unseen data

← Key concept!

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Density-based classifiers

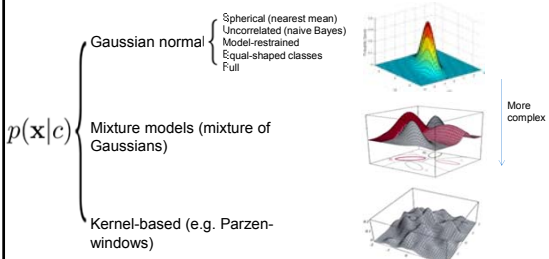
Model/estimate $p(\mathbf{x}|c)$

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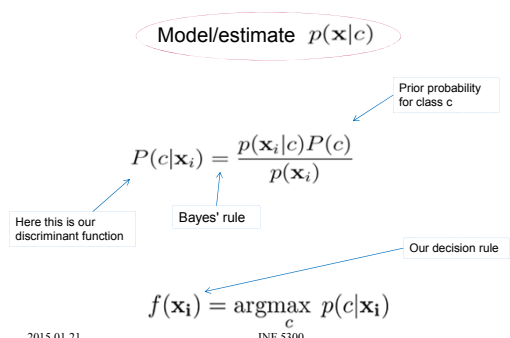
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(Density-based classifiers interlude)



Density-based classifiers cont.



Classification with Gaussian distributions

A "quite" popular density-based classifier

- \mathbf{x} normally distributed / Gaussian pdf:

$$p(x | \omega_s) = \frac{1}{(2\pi)^{d/2} |\Sigma_s|^{1/2}} \exp \left[-\frac{1}{2} (x - \mu_s)^T \Sigma_s^{-1} (x - \mu_s) \right]$$

- μ_s and Σ_s are generally not known, often using sample mean and sample covariance:

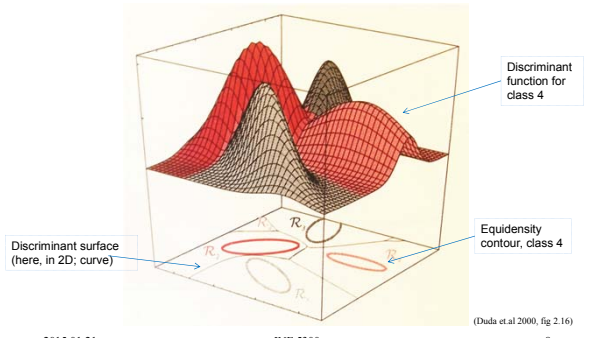
$$\hat{\mu}_s = \frac{1}{M_s} \sum_{m=1}^{M_s} x_m$$

$$\hat{\Sigma}_s = \frac{1}{M_s} \sum_{m=1}^{M_s} (x_m - \hat{\mu}_s)(x_m - \hat{\mu}_s)^T$$

where the sum is over all training samples belonging to class s

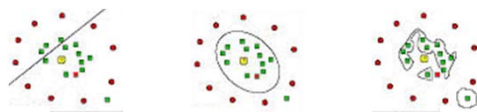
Often easier to work with $\log p(x|\omega_s)$

Gaussian distributions | example



Model complexity

- We seek a suitable model complexity to reveal «true» underlying structure
- However, one should not model «noise» or be prone to arbitrary sampling
- Goal: The location (in feature space) of a new, unseen sample should have correct label



2015.01.21 Cf. slide 5: increasing complexity -> INF 5300 9

Classifier performance

- Do not test your classifier using your training data!
- We are interested in how our classifier does on new, unobserved samples
- Separate training and test set
 - However, often a limited number of labeled data
- Can switch dataset roles for training and testing, cf. cross-validation

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Summary

- Decision rule and division of feature space
- Discriminant functions
- Probability-density-based classifiers
 - Often maximizing a posteriori probability, $p(c|x)$
- Model complexity, overfitting and the importance of a separate training and test set

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